

**Search Notes**

Application/Control No.

10/657,174

Examiner

M. Lee

Applicant(s)/Patent under  
Reexamination

MISHIMA ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	459	4/23/2006	ML
	443		
	441		
	451		
	452		
	699		
	700		
	701		
	455		
	448		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
interference search history printout		4/23/2006	ML

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/23/2006	ML